

FQT5P10 Datasheet

P-Channel 100-V (D-S) MOSFET

PRODU	CT SUMMARY			
V _{DS} (V)	R_{DS(on)} (Ω)	I _D (A)	Q _g (Typ.)	
- 100	0.200 at V _{GS} = - 10 V	- 3.0	13.2 nC	
- 100	0.230 at V _{GS} = - 6 V	- 2.4	13.2110	



FEATURES

- TrenchFET[®] Power MOSFET
- 100% Rg and UIS Tested

APPLICATIONS

- Active Clamp in Intermediate DC/ DC Power Supplies
- H-Bridge High Side Switch for Lighting Application

ABSOLUTE MAXIMUM RATINGS (Parameter	· A _ 0 0,	Symbol	Limit	Unit
				Unit
Drain-Source Voltage		V _{DS}	- 100	v
Gate-Source Voltage		V _{GS}	± 20	
	T _C = 25 °C		- 3.0	
Continuous Drain Current (T ₁ = 150 °C)	$T_{\rm C} = 70 ^{\circ}{\rm C}$		-2.1	
Continuous Diain Current (1j = 150°C)	T _A = 25 °C	I _D	- 2 ^{a, b}	
	T _A = 70 °C		- 1.6 ^{a, b}	Α
Pulsed Drain Current		I _{DM}	- 12	A
Oration of Decis Dirate Oracet	T _C = 25 °C		- 4.9	
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	- 2.5 ^{a, b}	
Avalanche Current	L = 0.1 mH	I _{AS}	- 15	
Single-Pulse Avalanche Energy	L = 0.1 mH	E _{AS}	11.25	mJ
	T _C = 25 °C		6.5	
	T _C = 70 °C		4.8	w
Maximum Power Dissipation	T _A = 25 °C	P _D	3.1 ^{a, b}	VV
	T _A = 70 °C	1 -	2 ^{a, b}	
Operating Junction and Storage Temperature Rang	e	T _J , T _{stq}	- 55 to 150	°C

P-Channel MOSFET

Notes:

a. Surface mounted on 1" x 1" FR4 board.

b. t = 10 s.

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^{a, b}	t ≤ 10 s	R _{thJA}	33	40	°C/W
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	17	21	0/11

Notes:

a. Surface mounted on 1" x 1" FR4 board.

b. Maximum under steady state conditions is 80 °C/W.

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static			•	•		
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = - 250 μA	- 100	1		V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	l _D = - 250 μA		- 165		
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μA		- 6.6		mV/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$	- 2		- 4	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA
Zaus Cata Malta na Dusia Cumunat	1	V _{DS} = - 100 V, V _{GS} = 0 V			- 1	
Zero Gate Voltage Drain Current	IDSS	V_{DS} = - 100 V, V_{GS} = 0 V, T_{J} = 55 °C			- 10	μA
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge -5 V$, $V_{GS} = -10 V$	- 8			Α
		V _{GS} = - 10 V, I _D = - 3 A		0.200		0
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 6 V, I _D = - 2 A		0.230		Ω
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 15 V, I _D = 3 A		12		S
Dynamic ^b			•	•		
Input Capacitance	C _{iss}			819		
Output Capacitance	C _{oss}	V _{DS} = - 35 V, V _{GS} = 0 V, f = 1 MHz		51		pF
Reverse Transfer Capacitance	C _{rss}			32		
Takal Oaka Okanaa	0	$V_{DS} = -50 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -3 \text{ A}$		17.5	32	25
Total Gate Charge	Qg			13.2	25	
Gate-Source Charge	Q _{gs}	V_{DS} = - 50 V, V_{GS} = - 6 V, I_D = - 3 A		3.4		nC
Gate-Drain Charge	Q _{gd}			6.4		
Gate Resistance	R _g	f = 1 MHz		6.1	9.2	Ω
Turn-On Delay Time	t _{d(on)}			10	20	
Rise Time	t _r	V_{DD} = - 50 V, R_L = 25 Ω		55	95	
Turn-Off DelayTime	t _{d(off)}	$I_D \cong$ - 3 A, V_{GEN} = - 6 V, R_g = 1 Ω		20	40	
Fall Time	t _f			15	30	
Turn-On Delay Time	t _{d(on)}			11	18	ns
Rise Time	t _r	V_{DD} = - 50 V, R_L = 25 Ω		18	32	
Turn-Off DelayTime	t _{d(off)}	${ m I}_{ m D}\cong$ - 3 A, ${ m V}_{ m GEN}$ = - 10 V, ${ m R}_{ m g}$ = 1 Ω		32	58	
Fall Time	t _f			20	35	
Drain-Source Body Diode Characterist	ics					
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			- 13	٨
Pulse Diode Forward Current ^a	I _{SM}				- 15	A
Body Diode Voltage	V _{SD}	I _S = - 3 A		- 0.8	- 1.2	V
Body Diode Reverse Recovery Time	t _{rr}			65	90	ns
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = - 3 A, dl/dt = 100 A/μs, T _{.I} = 25 °C		180	270	nC
Reverse Recovery Fall Time	t _a	$F = -3 A$, $di/dt = 100 A/\mu s$, $1 = 25 C$		45		
Reverse Recovery Rise Time	t _b			20		ns

Notes:

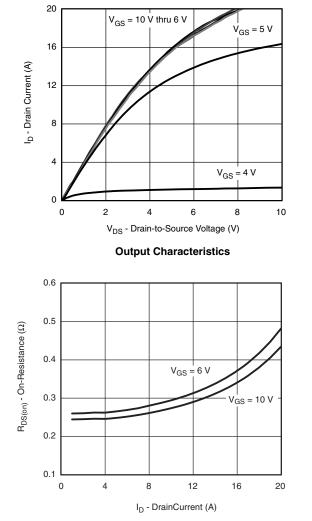
a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

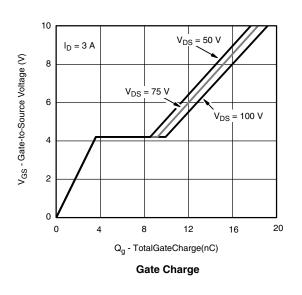
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

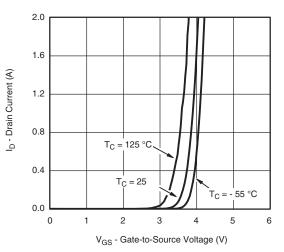
<u>VBsemi</u> Bsemi.com



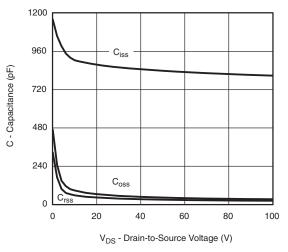


On-Resistance vs. Drain Current and Gate Voltage

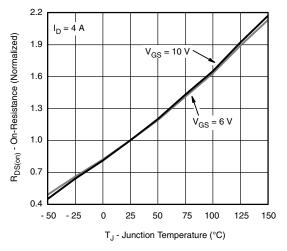




Transfer Characteristics

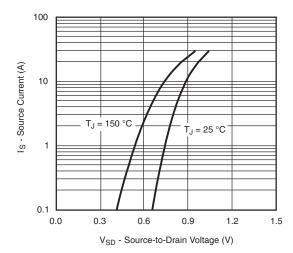


Capacitance

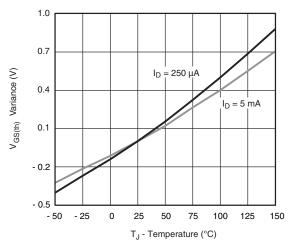


On-Resistance vs. Junction Temperature

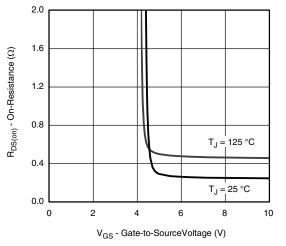




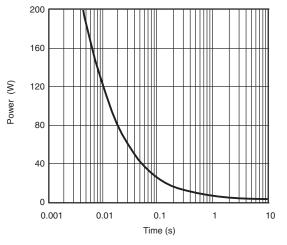




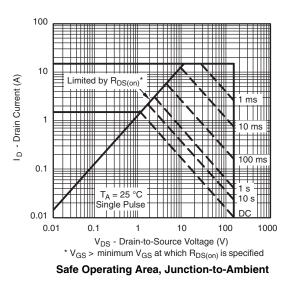
Threshold Voltage



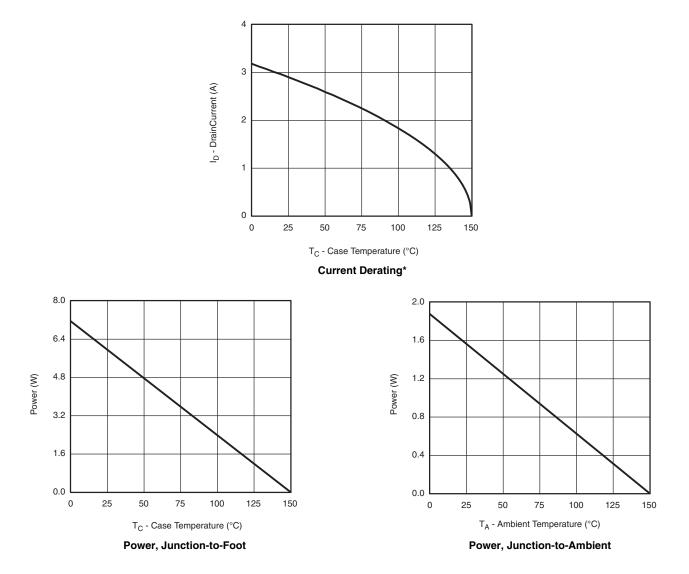
On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient

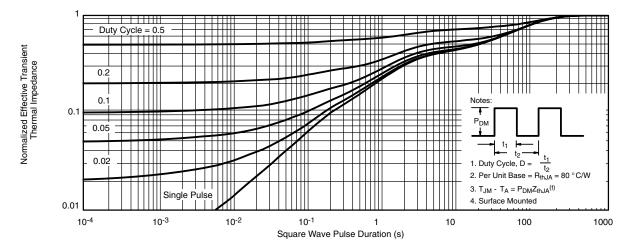




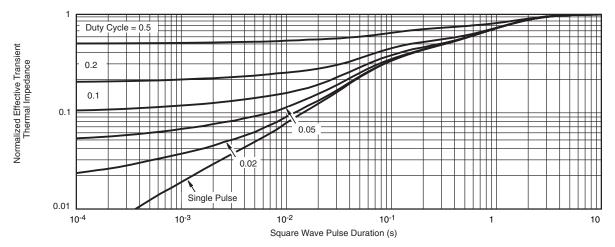


* The power dissipation P_D is based on $T_{J(max.)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





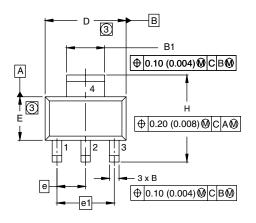
Normalized Thermal Transient Impedance, Junction-to-Ambient

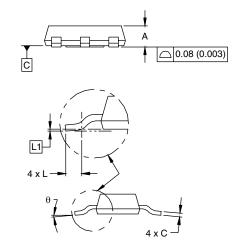


Normalized Thermal Transient Impedance, Junction-to-Foot



SOT-223 (HIGH VOLTAGE)





DIM.	MILLIMETERS		INCHES		
	MIN.	MAX.	MIN.	MAX.	
А	1.55	1.80	0.061	0.071	
В	0.65	0.85	0.026	0.033	
B1	2.95	3.15	0.116	0.124	
С	0.25	0.35	0.010	0.014	
D	6.30	6.70	0.248	0.264	
E	3.30	3.70	0.130	0.146	
е	2.30 BSC		0.0905 BSC		
e1	4.60 BSC		0.181 BSC		
Н	6.71	7.29	0.264	0.287	
L	0.91	-	0.036	-	
L1	0.061 BSC		0.002	4 BSC	
θ	-	10'	-	10'	

Notes

1. Dimensioning and tolerancing per ASME Y14.5M-1994.

2. Dimensions are shown in millimeters (inches).

3. Dimension do not include mold flash.

4. Outline conforms to JEDEC outline TO-261AA.



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